

Application/Control No.	Applicant(s)/Patent under Reexamination
10/806,887	MAHON ET AL.
Examiner	Art Unit
Alissa L. Hoey	3765

SEARCHED					
Class	Subclass	Date	Examiner		
2	updated search	9/7/2005	ALH		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
·				
•				